

Notice of References Cited	Application/Control No. 10/590,587		Applicant(s)/Patent Under Reexamination WATANABE ET AL.	
	Examiner Daniel J. Colilla		Art Unit 2854	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,763,031 A	08-1988	Wang, Patrick S.	310/83
*	B	US-4,930,916 A	06-1990	Fujiwara, Shinsuke	400/636
*	C	US-2001/0001273 A1	05-2001	Mori et al.	400/660
*	D	US-6,831,670 B2	12-2004	Fujiwara, Hitoshi	347/222
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 03118173 A	05-1991	Japan	IEMURA et al.	B41J 11/00
	O	JP 07237324 A	09-1995	Japan	MACHIDA et al.	B41J 11/00
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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